


<b>Search Notes</b>  	<b>Application/Control No.</b>  10773945	<b>Applicant(s)/Patent Under Reexamination</b>  SAYYAH, KEYVAN
	<b>Examiner</b>  Tran, Dzung D	<b>Art Unit</b>  2613

SEARCHED			
Class	Subclass	Date	Examiner
398	91, 115, 116	11/25/2007	TD
	Update search	06/07/2008	TD

SEARCH NOTES		
Search Notes	Date	Examiner
398/class as listed (USPAT; US-PGPUB; EPO; JPO and text search). See search history printout	11/25/2007	TD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner